

### LASER DIODE

## NDL7553P Series

## InGaAsP STRAINED MQW DC-PBH PULSED LASER DIODE MODULE 1550nm OTDR APPLICATION

#### **DESCRIPTION**

NDL7553P Series is a 1550nm newly developed Strained Multiple Quantum Well (st-MQW) structure pulsed laser diode coaxial module with singlemode fiber. It is designed for light source of optical measurement equipment (OTDR).

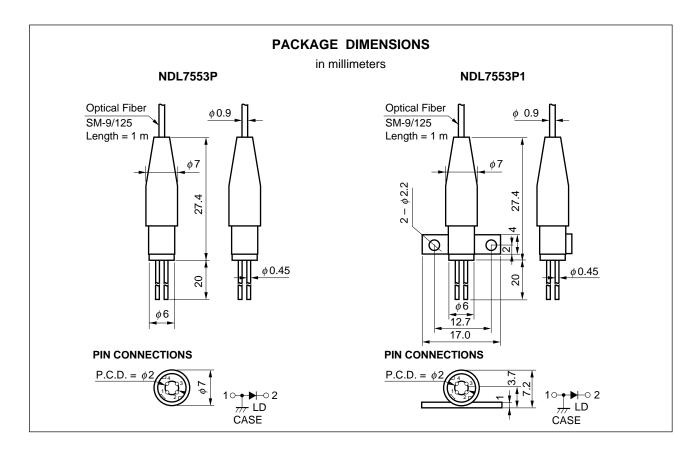
#### **FEATURES**

• High output power  $P_f = 145 \text{ mW } @I_{FP} = 1000 \text{ mA}^{-1}$ 

Long wavelength λc = 1550 nm
 Coaxial module without thermoelectric cooler.

Singlemode fiber pigtail

\*1 Pulse Conditions: Pulse width (PW) = 10  $\mu$ s, Duty = 1 %



The information in this document is subject to change without notice.



#### ORDERING INFORMATION

Part Number	Available Connector	Flange Type
NDL7553P	Without Connector	no flange
NDL7553PC	With FC-PC Connector	
NDL7553PD	With SC-PC Connector	
NDL7553P1	Without Connector	flat mount flange
NDL7553P1C	With FC-PC Connector	
NDL7553P1D	With SC-PC Connector	

#### ABSOLUTE MAXIMUM RATINGS (Tc = 25 °C)

Parameter	Symbol	Ratings	Unit
Pulsed Forward Current <sup>*1</sup>	IFP	1.2	Α
Reverse Voltage	VR	2.0	V
Operating Case Temperature	Tc	-20 to +60	°C
Storage Temperature	T <sub>stg</sub>	-40 to +85	°C
Lead Soldering Temperature (10 sec)	Tsld	260	°C

<sup>\*1</sup> Pulse Condition: Pulse Width (PW) = 10  $\mu$ s, Duty = 1 %

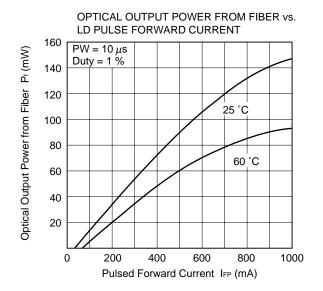
#### ELECTRO-OPTICAL CHARACTERISTICS (Tc = 25 °C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Forward Voltage	VFP	I <sub>FP</sub> = 1000 mA, PW = 10 μs, Duty = 1 %		2.5	4.0	V
Threshold Current	Ith			45	75	mA
Optical Output Power from Fiber	Pf	I <sub>FP</sub> = 1000 mA, PW = 10 μs, Duty = 1 %	95	145		mW
RMS Center Wavelength	λς	I <sub>FP</sub> = 1000 mA, PW = 10 μs, Duty = 1 %	1530	1550	1570	nm
RMS Spectral Width	σ	I <sub>FP</sub> = 1000 mA, PW = 10 μs, Duty = 1 %		7.5	10.0	nm
Rise Time	tr	10 - 90 %			2.0	ns
Fall Time	t <sub>f</sub>	90 - 10 %			2.0	ns

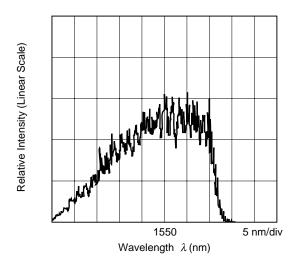
#### ELECTRO-OPTICAL CHARACTERISTICS (Tc = 0 to +60°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Threshold Current	Ith				100	mA
Optical Output Power from Fiber	Pf	IFP = 1000 mA, PW = 10 \( \mu s, \) Duty = 1 \( \% \)	60			mW
RMS Center Wavelength	λς	IFP = 1000 mA, PW = 10 \( \mu s, \) Duty = 1 \( \% \)	1520		1585	nm
Temperature Dependency of Center Wavelength	Δλ/ΔΤ			0.35		nm/°C
RMS Spectral Width	σ	IFP = 1000 mA, PW = 10 \( \mu s, \) Duty = 1 \%			10	nm

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#### LASER DIODE FAMILY FOR OTDR APPLICATION

Features	1.31 μ	m	1.55 μ	m	IFP*1		
Package	Part Number	P (mW) MIN./TYP.	Part Number	P (mW) MIN./TYP.	(mA)	Remarks	
φ5.6 CAN	NDL7103	290/320	NDL7153	220/240	1000		
	NDL7113	160/175	NDL7163	100/120	400		
4 pin Coaxial Module with SMF	NDL7503P/P1	110/180	NDL7553P/P1	95/145	1000	P : no flange	
	NDL7513P/P1	70/110	NDL7563P/P1	60/80	400	P1: with flange	
	NDL7514P/P1	25/50	NDL7564P/P1	20/40	400		
	NDL7515P/P1	20/30	NDL7565P/P1	8/11	400		
14 pin DIP Module with SMF	NDL7502P	125/190	NDL7552P	100/125	1000	with TEC and	
	NDL7512P	90/110	NDL7562P	70/80	400	Thermistor	
	NDL7510P	40/55	NDL7560P	20/30	400		

<sup>\*1</sup> Pulse conditions: pulse width = 10  $\mu$ s, duty = 1 % (modules) pulse width = 1  $\mu$ s, duty = 1 % ( $\phi$ 5.6 can)

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#### REFERENCE

Document Name	Document No.
NEC semiconductor device reliability/quality control system	LEI-1201
Quality grades on NEC semiconductor devices	C11531E
Semiconductor device mounting technology manual	C10535E
Guide to quality assurance for semiconductor devices	MEI-1202
Semiconductor selection guide	X10679E

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[MEMO]

[MEMO]

#### CAUTION

Within this module there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.



# AVOID EXPOSURE-Invisible Laser Radiation is emitted from

this aperture

SEMICONDUCTOR LASER

NEC Corporation NEC Building, 7-1, Shiba 5-chome, Minato-ku, Tokyo 108-01, Japan
Type number:
Manufactured:
Serial Number:
This product conforms to FDA
regulations as applicable
to standards 21 CFR Chapter 1.
Subchapter J.

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NEC devices are classified into the following three quality grades:

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Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

cial: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.

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